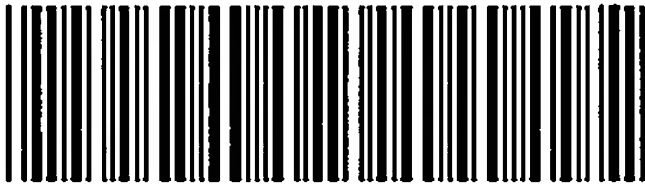


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,659	HSIEH ET AL.	
	Examiner	Art Unit	
	Edward H. Tso	2838	

SEARCHED			
Class	Subclass	Date	Examiner
320	107	3/1/2005	ET
	110		
	113		
	114		
	115		
713	300		
361	679		
	683		
	686		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR